

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/697,146	YAMAGISHI ET AL.
	Examiner	Art Unit
	Qi Han	2626

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
704	270	8/5/2006	QH
704	275	8/5/2006	QH
704	231,257	8/5/2006	QH